

DUE: FRIDAY, SEPTEMBER 18, 2015

Print your **name** and **NetID** legibly. Follow the guidelines and format given in the syllabus. Staple multiple pages. Show all units. Homework must be turned in at the **beginning** of class and any late homework assignments will not be accepted. Please contact the course director, Professor Dallesasse, should any issues with late homework arise.

## 1. FERMI-DIRAC STATISTICS

Show that

$$n_0 = N_c e^{-(E_c - E_F)/kT} \quad (1.1)$$

$$p_0 = N_v e^{-(E_F - E_v)/kT} \quad (1.2)$$

can be written as

$$n_0 = n_i e^{(E_F - E_i)/kT} \quad (1.3)$$

$$p_0 = n_i e^{(E_i - E_F)/kT} \quad (1.4)$$

If  $n_0 = 10^{15} \text{ cm}^{-3}$ , where is the Fermi level relative to  $E_i$  in Si at room temperature(300K)?

## 2. INTRINSIC CARRIER CONCENTRATION VS. TEMPERATURE 1

The electron concentration in a bar of silicon is  $2 \times 10^{13} \text{ cm}^{-3}$  at 300K under equilibrium conditions.

(A). What is the hole concentration?

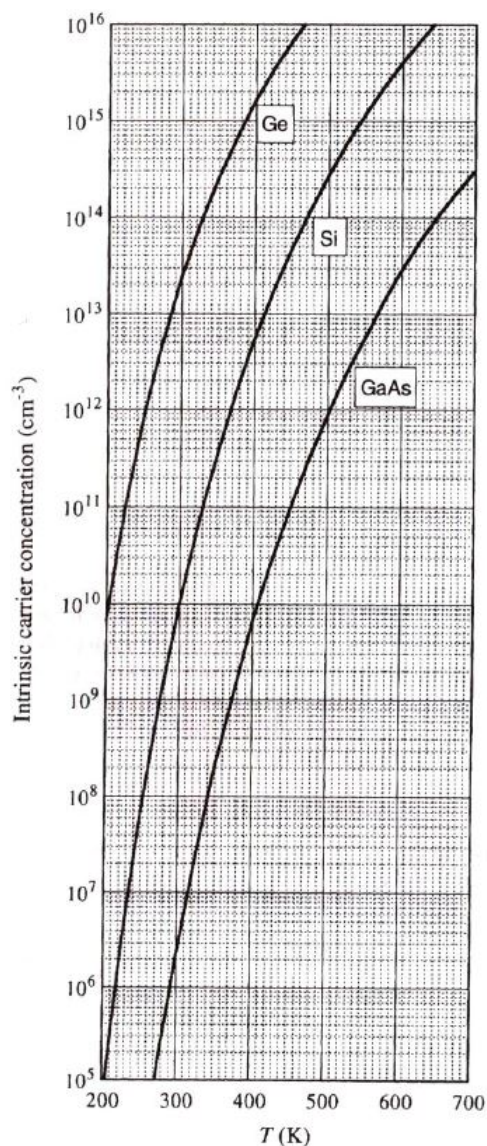
(B). Where is  $E_F$  positioned relative to  $E_i$ ?

(C). Draw the energy band diagram for the material.

(B). Repeat parts A, B, and C for the same sample if the temperature is 400K (refer to Fig. 3-17 in the Streetman text to obtain the intrinsic carrier concentration at 400K). You are given that the band gap energy is reduced to 1.08eV at 400K.

## 3. INTRINSIC CARRIER CONCENTRATION VS. TEMPERATURE 2

(A). Refer to the figure below.



Si	
$T(^{\circ}\text{C})$	$n_i(\text{cm}^{-3})$
0	$8.86 \times 10^8$
5	$1.44 \times 10^9$
10	$2.30 \times 10^9$
15	$3.62 \times 10^9$
20	$5.62 \times 10^9$
25	$8.60 \times 10^9$
30	$1.30 \times 10^{10}$
35	$1.93 \times 10^{10}$
40	$2.85 \times 10^{10}$
45	$4.15 \times 10^{10}$
50	$5.97 \times 10^{10}$
300 K	$1.00 \times 10^{10}$

GaAs	
$T(^{\circ}\text{C})$	$n_i(\text{cm}^{-3})$
0	$1.02 \times 10^5$
5	$1.89 \times 10^5$
10	$3.45 \times 10^5$
15	$6.15 \times 10^5$
20	$1.08 \times 10^6$
25	$1.85 \times 10^6$
30	$3.13 \times 10^6$
35	$5.20 \times 10^6$
40	$8.51 \times 10^6$
45	$1.37 \times 10^7$
50	$2.18 \times 10^7$
300 K	$2.25 \times 10^6$

Determine the temperature at which the intrinsic carrier concentration in Si and GaAs are equal to the room temperature (300K) intrinsic carrier concentration of Ge.

(B). Semiconductor A has a bandgap of 2.5eV. Semiconductor B has a bandgap of 1.5eV. What is the ratio of the intrinsic carrier concentrations ( $n_{iA}/n_{iB}$ ) at 300K? Assume any differences in the carrier effective masses may be neglected.

**4. CARRIER CONCENTRATIONS OF COMPENSATED SEMICONDUCTORS**

A compensated Germanium sample ( $n_i = 2 \times 10^{13} \text{ cm}^{-3}$ ) is doped with  $10^{15} \text{ cm}^{-3}$  acceptors and  $4 \times 10^{13} \text{ cm}^{-3}$  donors.

- (A). Calculate the electron and hole concentrations at room temperature (300K) under equilibrium conditions.
- (B). Repeat part (A) for  $10^{14} \text{ cm}^{-3}$  acceptors and  $4 \times 10^{13} \text{ cm}^{-3}$  donors.
- (C). Repeat part (A) for  $4.1 \times 10^{13} \text{ cm}^{-3}$  acceptors and  $4 \times 10^{13} \text{ cm}^{-3}$  donors.
- (D). Determine the percentage of error in each case for the majority carrier concentration if one simply assumes that the majority carrier concentration approximately equals the difference between the donor and acceptor doping. What can you say about the accuracy of this approximation?